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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/697,557	RAPPAPORT ET AL.	
Examiner	Art Unit	•
Akash Saxena	2128	

	SEARCHED		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Reviewed cited art in view of the claim amendment	11/2/2007	AS
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